# BLC10G18XS-550AVT

# Power LDMOS transistor Rev. 1 — 21 December 2017

**AMMPLEON** 

Product data sheet

#### **Product profile** 1.

### 1.1 General description

550 W LDMOS packaged asymmetric Doherty power transistor for base station applications at frequencies from 1805 MHz to 1880 MHz.

#### Typical performance

Typical RF performance at  $T_{case} = 25$  °C in an asymmetrical Doherty production test circuit.  $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA (main);  $V_{GS(amp)peak}$  = 0.95 V, unless otherwise specified.

Test signal	f	V <sub>DS</sub>	P <sub>L(AV)</sub>	G <sub>p</sub>	η <sub>D</sub>	ACPR
	(MHz)	(V)	(W)	(dB)	(%)	(dBc)
1-carrier W-CDMA	1805 to 1880	28	91	16.5	49.3	-29.4 <sup>[1]</sup>

<sup>[1]</sup> Test signal: 1-carrier W-CDMA; 3GPP test model 1; 64 DPCH; PAR = 9.9 dB at 0.01 % probability on

### 1.2 Features and benefits

- Excellent ruggedness
- High efficiency
- Low thermal resistance providing excellent thermal stability
- Lower output capacitance for improved performance in Doherty applications
- Designed for low memory effects providing excellent digital pre-distortion capability
- Internally matched for ease of use
- Integrated ESD protection
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

### 1.3 Applications

RF power amplifiers for base stations and multi carrier applications in the 1805 MHz to 1880 MHz frequency range

# 2. Pinning information

Table 2. Pinning

Pin	Description		Simplified outline	Graphic symbol
1	drain2 (peak)			0.7
2	drain1 (main)		7 2 1 6	2, 7
3	gate1 (main)		5	<u> </u>
4	gate2 (peak)		3 4	3——5
5	source	[1]		4—
6	video decoupling (peak)			<u>'</u>
7	video decoupling (main)			1, 6 aaa-014884

<sup>[1]</sup> Connected to flange.

# 3. Ordering information

Table 3. Ordering information

Type number	Packag	Package				
	Name	Description	Version			
BLC10G18XS-550AVT	-	air cavity plastic earless flanged package; 6 leads	SOT1258-4			

# 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	65	V
V <sub>GS(amp)main</sub>	main amplifier gate-source voltage	-6	+9	V	
V <sub>GS(amp)peak</sub>	peak amplifier gate-source voltage		-6	+9	V
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature	[1]	-	225	°C
T <sub>case</sub>	case temperature	operating [1]	-40	+125	°C

<sup>[1]</sup> Continuous use at maximum temperature will affect the reliability, for details refer to the online MTF calculator.

# 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
R <sub>th(j-c)</sub>	thermal resistance from junction	$V_{DS}$ = 32 V; $I_{Dq}$ = 800 mA (main);		
	to case	V <sub>GS(amp)peak</sub> = 1.1 V; T <sub>case</sub> = 80 °C		
		P <sub>L</sub> = 110 W	0.187	k/W
		P <sub>L</sub> = 138 W	0.166	k/W

BLC10G18XS-550AVT

## 6. Characteristics

 Table 6.
 DC characteristics

T:	= 25	90	unless	otherwise	specified
Ιį	- 25	$^{\circ}$	unincoo	OUTE WISE	Specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Main dev	rice					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 1.8 \text{ mA}$	65	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 180 mA	1.5	2.0	2.5	V
$V_{GSq}$	gate-source quiescent voltage	$V_{DS}$ = 28 V; $I_{D}$ = 800 mA	-	2.2	-	V
I <sub>DSS</sub>	drain leakage current	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 32 V	-	-	2.8	μΑ
I <sub>DSX</sub>	drain cut-off current	$V_{GS} = V_{GS(th)} + 2.37 \text{ V}$	-	34	-	Α
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 9 V; V <sub>DS</sub> = 0 V	-	-	280	nΑ
9 <sub>fs</sub>	forward transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 9.0 A	-	20.5	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 2.37 \text{ V};$ $I_D = 6.3 \text{ A}$	-	72	108	mΩ
Peak dev	rice					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 3.8 \text{ mA}$	65	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$V_{DS}$ = 10 V; $I_{D}$ = 380 mA	1.5	2.0	2.5	V
$V_{GSq}$	gate-source quiescent voltage	V <sub>DS</sub> = 28 V; I <sub>D</sub> = 2000 mA	-	2.2	-	V
I <sub>DSS</sub>	drain leakage current	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 32 V	-	-	2.8	μΑ
I <sub>DSX</sub>	drain cut-off current	$V_{GS} = V_{GS(th)} + 2.37 \text{ V}$	-	57	-	Α
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 9 V; V <sub>DS</sub> = 0 V	-	-	280	nΑ
g <sub>fs</sub>	forward transconductance	V <sub>DS</sub> = 10 V; I <sub>D</sub> = 19.0 A	-	39.0	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 2.37 \text{ V};$ $I_D = 13.3 \text{ A}$	-	37	62	mΩ

#### Table 7. RF characteristics

Test signal: 1-carrier W-CDMA; PAR = 9.6 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 1 to 64 DPCH;  $f_1$  = 1807.5 MHz;  $f_2$  = 1877.5 MHz; RF performance at  $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA (main);  $V_{GS(amp)peak}$  = 1.0 V;  $T_{case}$  = 25 °C; unless otherwise specified; in an asymmetrical Doherty production test circuit at frequencies from 1805 MHz to 1880 MHz.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
G <sub>p</sub>	power gain	P <sub>L(AV)</sub> = 93 W	15.0	16.0	-	dB
RLin	input return loss	P <sub>L(AV)</sub> = 93 W	-	-19	-13	dB
$\eta_{D}$	drain efficiency	P <sub>L(AV)</sub> = 93 W	45	50	-	%
ACPR	adjacent channel power ratio	P <sub>L(AV)</sub> = 93 W	-	-26	-22	dBc

#### Table 8. RF characteristics

Test signal: 1-carrier W-CDMA; PAR = 9.6 dB at 0.01 % probability on the CCDF; 3GPP test model 1; 1 to 64 DPCH; f = 1807.5 MHz; RF performance at  $V_{DS}$  = 28 V;  $I_{Dq}$  = 800 mA (main);  $V_{GS(amp)peak}$  = 1.0 V;  $T_{case}$  = 25 °C; unless otherwise specified; in an asymmetrical Doherty production test circuit at a frequency of 1805 MHz.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
PARO	output peak-to-average ratio	P <sub>L(AV)</sub> = 118 W	5.8	6.3	-	dB
$P_{L(M)}$	peak output power	P <sub>L(AV)</sub> = 118 W	440	510	-	W

# 7. Test information

# 7.1 Ruggedness in Doherty operation

The BLC10G18XS-550AVT is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:  $V_{DS}$  = 32 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 1.05 V; f = 1807.5 MHz;  $P_L$  = 213 W (5 dB OBO); 46 % clipping.

# 7.2 Impedance information

Table 9. Typical impedance of main device Measured load-pull data of main device;  $I_{Dq}$  = 1000 mA (main);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)
Maximun	n power load				
1805	1.4 – 4.9i	1.8 – 3.1i	269	62.8	17.6
1845	1.6 – 5.2i	1.8 – 3.1i	266	63.2	18.0
1880	2.1 – 5.6i	1.7 – 3.2i	265	60.7	18.0
Maximun	n drain efficiency	load			
1805	1.4 – 4.9i	3.1 – 2.3i	213	69.6	19.4
1845	1.6 – 5.2i	2.8 – 2.3i	216	69.3	19.6
1880	2.1 – 5.6i	2.5 – 2.1i	211	69.2	19.7

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

<sup>[2]</sup> At 3 dB gain compression.

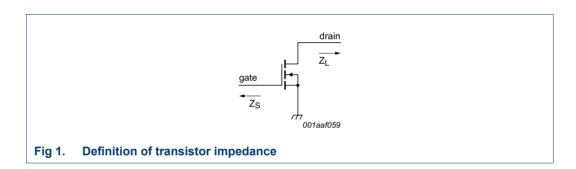
Table 10. Typical impedance of peak device

Measured load-pull data of peak device;  $I_{Dq}$  = 2100 mA (peak);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]				
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)				
Maximum	Maximum power load								
1805	1.7 – 5.6i	1.0 – 3.3i	488	57.6	15.8				
1845	2.0 – 6.0i	1.0 – 3.4i	481	56.3	16.0				
1880	2.6 – 6.5i	1.1 – 3.5i	475	56.0	16.2				
Maximum	drain efficiency	load							
1805	1.7 – 5.6i	1.7 – 2.6i	378	66.0	17.7				
1845	2.0 – 6.0i	1.5 – 2.4i	343	65.4	18.2				
1880	2.6 – 6.5i	1.5 – 2.5i	356	65.1	18.2				

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

<sup>[2]</sup> At 3 dB gain compression.



# 7.3 Recommended impedances for Doherty design

#### Table 11. Typical impedance of main at 1:1 load

Measured load-pull data of main device;  $I_{Dq}$  = 1000 mA (main);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L(3dB)</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)
1805	1.7 – j5.0	1.8 – j3.6	244	39.9	20.0
1845	2.1 – j5.3	1.7 – j3.3	247	40.5	20.4
1880	2.5 – j5.7	1.7 – j3.0	247	41.7	20.8

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

[2] At  $P_{L(AV)} = 115 \text{ W}$ .

Table 12. Typical impedance of main device at 1: 2.5 load

Measured load-pull data of main device;  $I_{Dq}$  = 1000 mA (main);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L(3dB)</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)
1805	1.7 – j5.0	3.9 – j1.3	144	55.5	22.9
1845	2.1 – j5.3	3.8 – j1.1	134	56.5	23.5
1880	2.5 – j5.7	3.8 – j0.8	124	56.4	23.9

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

#### Table 13. Typical impedance of peak device at 1:1 load

Measured load-pull data of peak device;  $I_{Dq}$  = 2100 mA (peak);  $V_{DS}$  = 28 V; pulsed CW ( $t_p$  = 100  $\mu$ s;  $\delta$  = 10 %).

f	Z <sub>S</sub> [1]	Z <sub>L</sub> [1]	P <sub>L(3dB)</sub> [2]	η <sub>D</sub> [2]	G <sub>p</sub> [2]
(MHz)	<b>(</b> Ω <b>)</b>	<b>(</b> Ω <b>)</b>	(W)	(%)	(dB)
1805	1.6 – j5.1	1.7 – j3.9	397	31.5	18.7
1845	2.0 - j5.5	1.6 – j3.7	416	31.2	19.0
1880	3.0 – j6.4	1.5 – j3.5	422	31.5	19.4

<sup>[1]</sup>  $Z_S$  and  $Z_L$  defined in Figure 1.

Table 14. Off-state impedances of peak device

f	Z <sub>off</sub>
(MHz)	$(\Omega)$
1805	1.0 – j1.2
1845	0.7 – j0.4
1880	0.5 + j0.2

<sup>[2]</sup> At  $P_{L(AV)} = 115 \text{ W}$ .

<sup>[2]</sup> At  $P_{L(AV)} = 115 W$ .

### 7.4 Test circuit

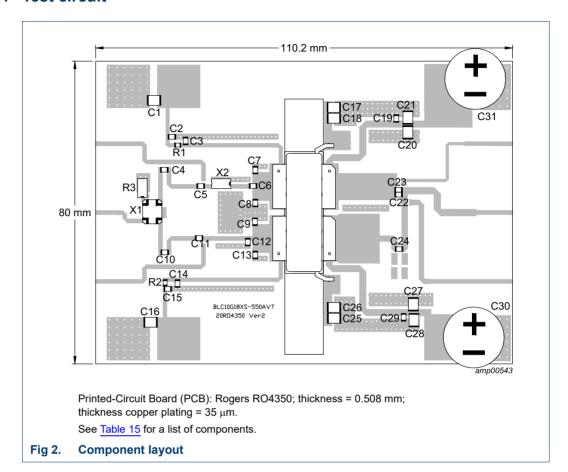
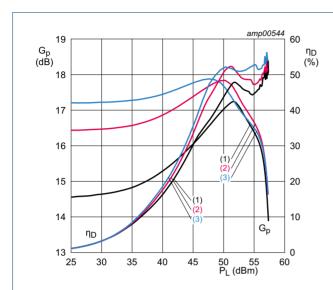


Table 15. List of components
See Figure 2 for component layout.

Component	Description	Value	Remarks
C1, C16, C17, C18, C20, C21, C25, C26, C27, C28	multilayer ceramic chip capacitor	4.7 μF, 50 V	SMD 1210, Murata: GRM32ER71H475KA88L
C2, C15	multilayer ceramic chip capacitor	100 nF, 50 V	GRM21BR71H104KA01L
C3, C4, C5, C6,C10, C11, C14, C19, C24, C29	multilayer ceramic chip capacitor	10 pF	SMD 0805, ATC 600F HiQ, 250 V
C7, C9, C22, C23	multilayer ceramic chip capacitor	2.0 pF	SMD 0805, ATC 600F HiQ, 250 V
C8, C13	multilayer ceramic chip capacitor	1.8 pF	SMD 0805, ATC 600F HiQ, 250 V
C12	multilayer ceramic chip capacitor	0.5 pF	SMD 0805, ATC 600F HiQ, 250 V
C30, C31	electrolytic capacitor	470 μF, 60 V	
R1, R2	resistor	4.7 Ω, 1 %	SMD 0805
R3	resistor	50 Ω, 25 W	Anaren: C16A50Z4
X1	hybrid coupler	2 dB, 90°	Anaren Xinger III: X3C20F1-02
X2	attenuator	2 dB, 7 W	Anaren: D10AA2Z4

## 7.5 Graphical data

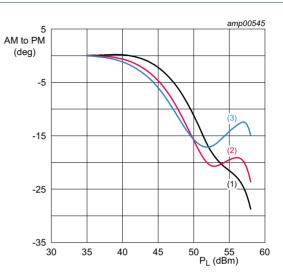
## 7.5.1 Pulsed CW



 $V_{DS} = 32 \text{ V}; I_{Dq} = 800 \text{ mA}; V_{GS(amp)peak} = 1.05 \text{ V}.$ 

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 3. Power gain and drain efficiency as function of output power; typical values



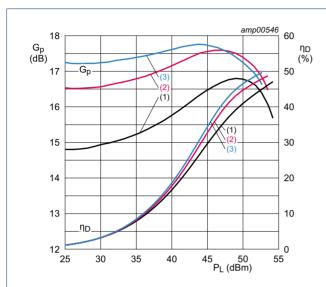
 $V_{DS}$  = 32 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 1.05 V.

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 4. Normalized AM to PM as a function of output power; typical values

#### 7.5.2 1-Carrier W-CDMA

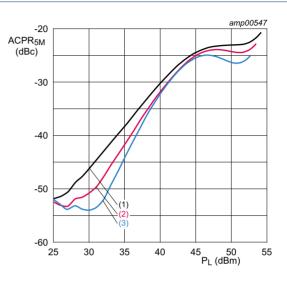
Test signal: 3GPP test model 1; 1 to 64 DPCH (100 % clipping): PAR = 7.5 dB per carrier at 0.01 % probability on CCDF per carrier.



 $V_{DS} = 32 \text{ V}; I_{Dq} = 800 \text{ mA}; V_{GS(amp)peak} = 1.05 \text{ V}.$ 

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

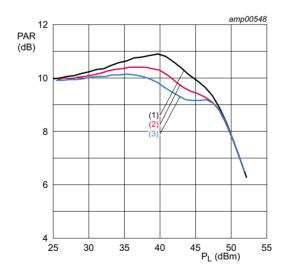
Fig 5. Power gain and drain efficiency as function of output power; typical values



 $V_{DS}$  = 32 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 1.05 V.

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 6. Adjacent channel power ratio (5 MHz) as a function of output power; typical values



 $V_{DS}$  = 32 V;  $I_{Dq}$  = 800 mA;  $V_{GS(amp)peak}$  = 1.05 V.

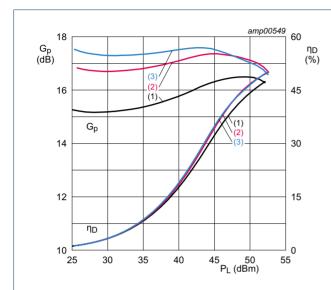
- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 7. Peak-to-average power ratio as a function of output power; typical values

BLC10G18XS-550AVT

#### 7.5.3 2-Carrier W-CDMA

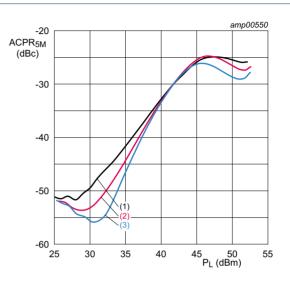
Test signal: 3GPP test model 1; 1 to 64 DPCH (46 % clipping): PAR = 7.5 dB per carrier at 0.01 % probability on CCDF per carrier.



 $V_{DS} = 32 \text{ V}; I_{Dq} = 800 \text{ mA}; V_{GS(amp)peak} = 1.05 \text{ V}.$ 

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 8. Power gain and drain efficiency as function of output power; typical values

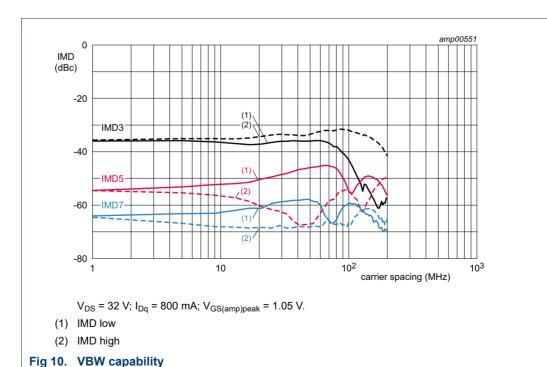


 $V_{DS} = 32 \text{ V}; I_{Dq} = 800 \text{ mA}; V_{GS(amp)peak} = 1.05 \text{ V}.$ 

- (1) f = 1805 MHz
- (2) f = 1842.5 MHz
- (3) f = 1880 MHz

Fig 9. Adjacent channel power ratio (5 MHz) as a function of output power; typical values

### 7.5.4 2-Tone VBW

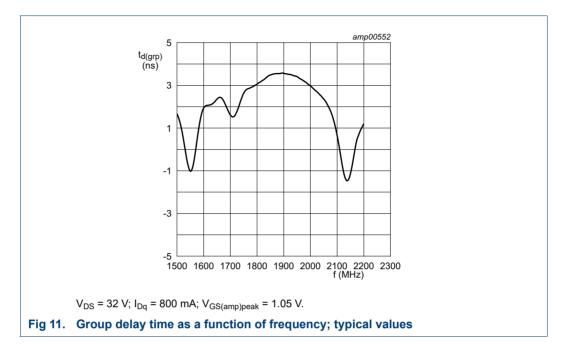


BLC10G18XS-550AVT

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## 7.5.5 Group delay



# 8. Package outline

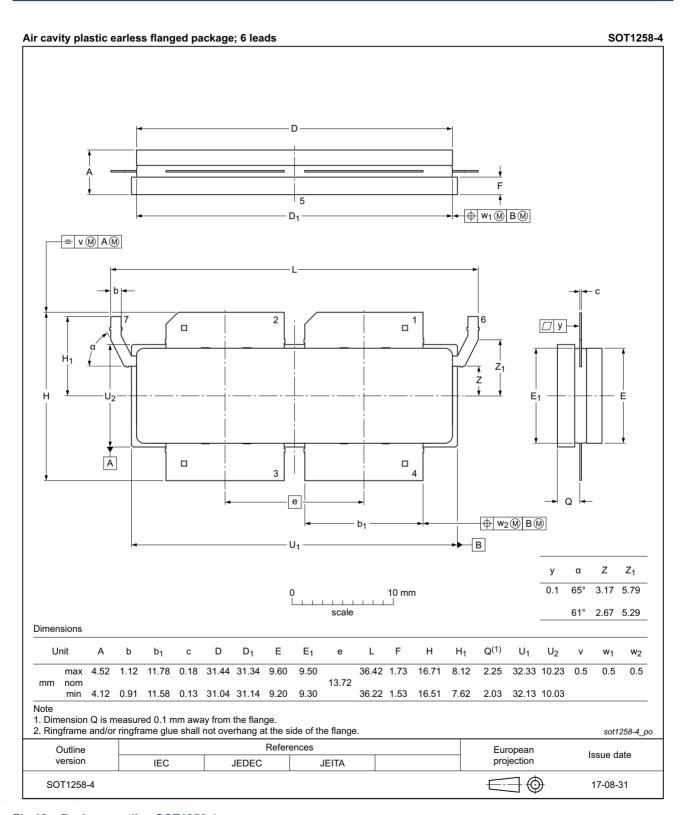


Fig 12. Package outline SOT1258-4

# 9. Handling information

#### **CAUTION**



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

Table 16. ESD sensitivity

ESD model	Class
Charged Device Model (CDM); According to ANSI/ESDA/JEDEC standard JS-002	C3 [1]
Human Body Model (HBM); According to ANSI/ESDA/JEDEC standard JS-001	2 [2]

- [1] CDM classification C3 is granted to any part that passes after exposure to an ESD pulse of 1000 V.
- [2] HBM classification 2 is granted to any part that passes after exposure to an ESD pulse of 2000 V, but fails after exposure to an ESD pulse of 4000 V.

## 10. Abbreviations

Table 17. Abbreviations

Acronym	Description
3GPP	3rd Generation Partnership Project
CCDF	Complementary Cumulative Distribution Function
CW	Continuous Wave
DPCH	Dedicated Physical CHannel
ESD	ElectroStatic Discharge
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
MTF	Median Time to Failure
ОВО	Output Back Off
PAR	Peak-to-Average Ratio
SMD	Surface Mounted Device
VBW	Video BandWidth
VSWR	Voltage Standing Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

# 11. Revision history

Table 18. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLC10G18XS-550AVT v.1	20171221	Product data sheet	-	-

# 12. Legal information

#### 12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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BLC10G18XS-550AVT

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# **BLC10G18XS-550AVT**

#### **Power LDMOS transistor**

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### **Power LDMOS transistor**

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